

## Notice of References Cited

Application/Control No. \_ Applicant(s)/Patent Under Reexamination MAIYURAN ET AL.

Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,495,617	02-1996	Yamada, Kouichi	713/323
	В	US-5,634,131	05-1997	Matter et al.	713/322
	С	US-6,608,476	08-2003	Mirov et al.	324/103R
	D	US-5,931,951	08-1999	Ando, Motoaki	713/324
	E	US-6,442,667	08-2002	Shiell et al.	711/207
	F	US-5,666,513	09-1997	Whittaker, Bruce Ernest	711/118
	G	US-5,410,668	04-1995	Hilton, Ronald N.	711/139
	Н	US-6,427,188	07-2002	Lyon et al.	711/122
	ı	US-5,630,146	05-1997	Conary et al.	713/322
	j	US-6,219,796	04-2001	Bartley, David Harold	713/320
	К	US-6,307,281	10-2001	Houston, Theodore W.	307/31
	L	US-5,809,532	09-1998	Eno et al.	711/141
	М	US-5,901,322	05-1999	Herbst et al.	713/322

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z	WO 97/37307	10-1997	EPO	Mates et al.	G06F 13/00
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	R					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.